N-channel LFPAK 40 V 4.2 mΩ standard level MOSFET

Rev. 02 — 12 July 2010

Product data sheet

#### **Product profile** 1.

#### **1.1 General description**

Standard level N-channel MOSFET in LFPAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

#### 1.2 Features and benefits

- Advanced TrenchMOS provides low RDSon and low gate charge
- High efficiency gains in switching power converters

#### 1.3 Applications

- DC-to-DC convertors
- Lithium-ion battery protection
- Load switching

### Improved mechanical and thermal characteristics

- LFPAK provides maximum power density in a Power SO8 package
- Motor control
- Server power supplies

#### 1.4 Quick reference data

Table 1.	Quick reference	data				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	-	40	V
I <sub>D</sub>	drain current	T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 10 V; see <u>Figure 1</u>	-	-	100	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	-	106	W
Tj	junction temperature		-55	-	175	°C
Static cha	aracteristics					
R <sub>DSon</sub>	drain-source on-state	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 15 A; T <sub>j</sub> = 100 °C; see <u>Figure 12</u>	-	-	5.6	mΩ
	resistance	$\label{eq:VGS} \begin{array}{l} V_{GS} = 10 \text{ V}; \text{ I}_{D} = 15 \text{ A}; \\ T_{j} = 25 \text{ °C}; \text{ see } \underline{\text{Figure } 12}; \\ \text{see } \underline{\text{Figure } 13} \end{array}$	-	3.2	4.2	mΩ



## PSMN4R0-40YS

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Table 1.	Quick refere	nce data	continued
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Symbol	Parameter	Conditions	Mir	Тур	Max	Unit
Dynamic of	characteristics					
Q <sub>GD</sub>	gate-drain charge	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$	-	7	-	nC
Q <sub>G(tot)</sub>	total gate charge	V <sub>DS</sub> = 20 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	38	-	nC
Avalanche ruggedness						
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy		-	-	77	mJ

### 2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		-
2	S	source	mb	
3	S	source		
4	G	gate		
mb	D	drain	ប៉ូប៉ូប៉ូប៉ូ	mbb076 Ś
			SOT669 (LFPAK)	

### 3. Ordering information

Table 3. Ordering in	formation		
Type number	Package		
	Name	Description	Version
PSMN4R0-40YS	LFPAK	plastic single-ended surface-mounted package (LFPAK); 4 leads	SOT669

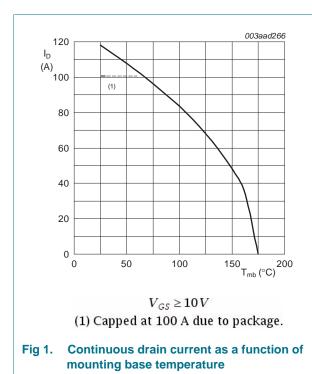
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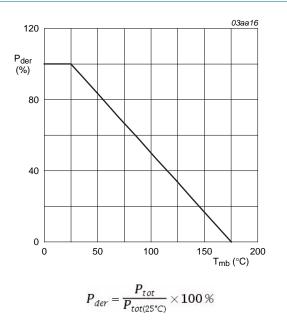
### 4. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	40	V
V <sub>DGR</sub>	drain-gate voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C; R <sub>GS</sub> = 20 kΩ	-	40	V
V <sub>GS</sub>	gate-source voltage		-20	20	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; see <u>Figure 1</u>	-	83	А
		$V_{GS}$ = 10 V; $T_{mb}$ = 25 °C; see <u>Figure 1</u>	-	100	А
I <sub>DM</sub>	peak drain current	pulsed; t <sub>p</sub> ≤ 10 µs; T <sub>mb</sub> = 25 °C; see <u>Figure 3</u>	-	472	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	106	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
T <sub>sld(M)</sub>	peak soldering temperature		-	260	°C
Source-drai	n diode				
I <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C	-	100	А
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^{\circ}C$	-	472	А
Avalanche r	uggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 100 A; $V_{sup} \le 40$ V; unclamped; $R_{GS}$ = 50 $\Omega$	-	77	mJ

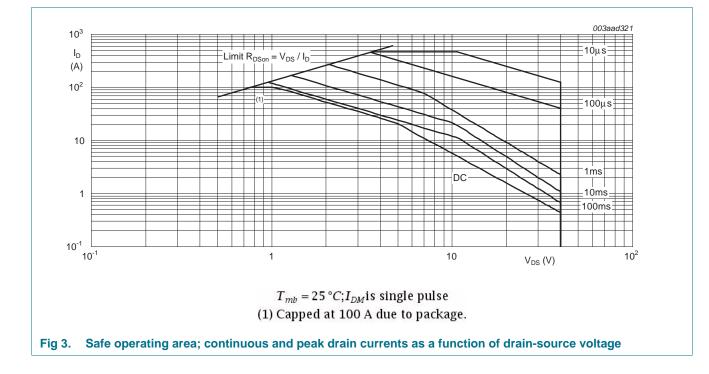






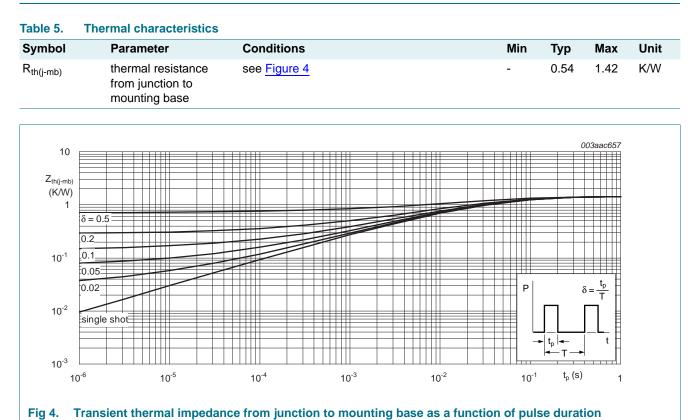
## **PSMN4R0-40YS**

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### 5. Thermal characteristics



N-channel LFPAK 40 V 4.2 mΩ standard level MOSFET

### 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics					
V <sub>(BR)DSS</sub>	drain-source	$I_D = 250 \ \mu A; V_{GS} = 0 \ V; T_j = -55 \ ^{\circ}C$	36	-	-	V
	breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^\circ C$	40	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 10</u> ; see <u>Figure 11</u>	-	-	4.6	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see Figure 10; see Figure 11	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see Figure 10; see Figure 11	2	3	4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	3	μA
		$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$	-	-	40	μA
I <sub>GSS</sub>	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	100	nA
		$V_{GS}$ = -20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	-	100	nA
DOON	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 15 A; T <sub>j</sub> = 100 °C; see <u>Figure 12</u>	-	-	5.6	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 15 A; T <sub>j</sub> = 175 °C; see <u>Figure 12</u>	-	-	8	mΩ
		$V_{GS}$ = 10 V; $I_D$ = 15 A; $T_j$ = 25 °C; see Figure 12; see Figure 13	-	3.2	4.2	mΩ
R <sub>G</sub>	internal gate resistance (AC)	f = 1 MHz	-	0.62	-	Ω
Dynamic ch	aracteristics					
$Q_{G(tot)}$ total gate charge		$I_D = 0 \text{ A}; \text{ V}_{DS} = 0 \text{ V}; \text{ V}_{GS} = 10 \text{ V}$	-	31	-	nC
		$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 10 \text{ V};$	-	38	-	nC
Q <sub>GS</sub>	gate-source charge	see Figure 14; see Figure 15	-	12	-	nC
Q <sub>GS(th)</sub>	pre-threshold gate-source charge	$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 10 \text{ V};$ see Figure 14	-	7	-	nC
Q <sub>GS(th-pl)</sub>	post-threshold gate-source charge		-	5	-	nC
Q <sub>GD</sub>	gate-drain charge	$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	7	-	nC
V <sub>GS(pl)</sub>	gate-source plateau voltage	$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; \text{ see } \frac{\text{Figure } 14}{100000000000000000000000000000000000$	-	4.8	-	V
C <sub>iss</sub>	input capacitance	$V_{DS} = 20 \text{ V}; \text{ V}_{GS} = 0 \text{ V}; \text{ f} = 1 \text{ MHz};$	-	2410	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 16</u>	-	504	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	266	-	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 20 \text{ V}; \text{ R}_{L} = 0.8 \Omega; \text{ V}_{GS} = 10 \text{ V};$	-	18	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 4.7 \ \Omega$	-	19	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	34	-	ns
t <sub>f</sub>	fall time		-	12	-	ns

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Symbol

Source-drain diode

## **PSMN4R0-40YS**

Тур

Max

Unit

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Min

	source-drain voltage	I <sub>S</sub> = 25 A; V <sub>GS</sub> = 0 V see <u>Figure 17</u>	′; T <sub>j</sub> = 25 °C;	-	0.83	1.2	V
r	reverse recovery time		00 A/µs; V <sub>GS</sub> = 0 V;	-	42	-	ns
Q <sub>r</sub>	recovered charge	$V_{DS} = 20 V$		-	45	-	nC
100 80 60 40 20 0 0	1 2 $T_j = 25 ^{\circ}C$	003aad154	$20 \qquad -T_j = 1$	4 $V_{DS} = 25$	T <sub>j</sub> = 25 °C	8 V <sub>GS</sub> (V)	
	tput characteristics: drai ction of drain-source vol		Fig 6. Transfer cha function of				
4000 C (pF) 3000		003aad159	80 g <sub>fs</sub> (S) 60			003aad160	
C (pF) 3000 2000			9 <sub>fs</sub> (S) 60 40			003aad160	
C (pF) 3000		C <sub>iss</sub>	g <sub>fs</sub> (S) 60	40	60	003aad160	
C (pF) 3000 2000 1000 0 0 0	$\frac{1}{3} = 0 V; f = 1MH$ ut and reverse transfer of ction of gate-source volt	C <sub>iss</sub> C <sub>iss</sub> C <sub>rss</sub> C <sub>rss</sub> 9 V <sub>GS</sub> (V) <sup>12</sup> Iz	$\begin{array}{c} g_{fs} \\ (S) \\ 60 \\ 40 \\ 20 \\ 0 \\ 0 \\ 0 \\ 20 \end{array}$	$= 25 ^{\circ}C; V_{DS}$	60 e = 25 V	I <sub>D</sub> (A) <sup>80</sup>	n of

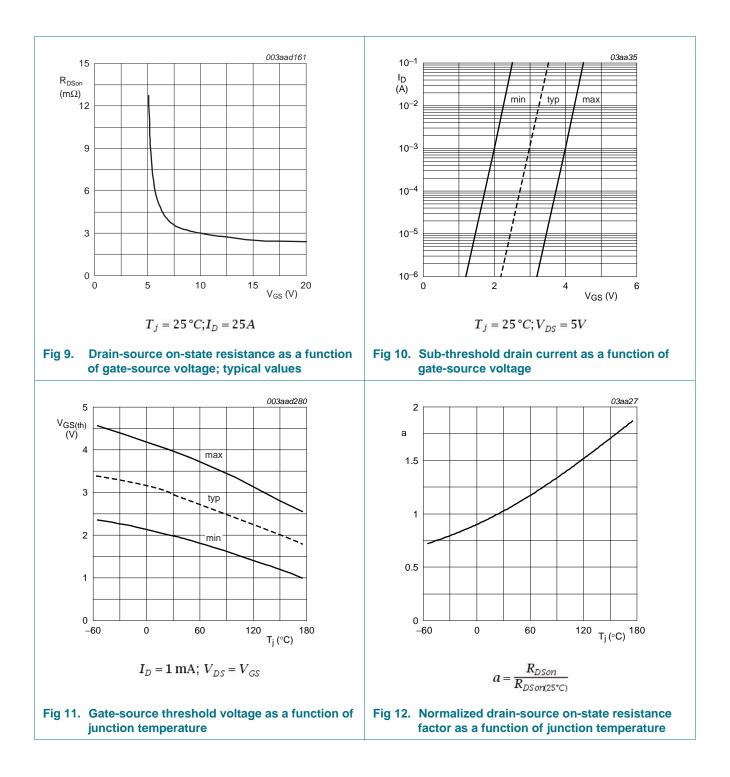
Table 6. Characteristics ... continued Tested to JEDEC standards where applicable.

Parameter

Conditions

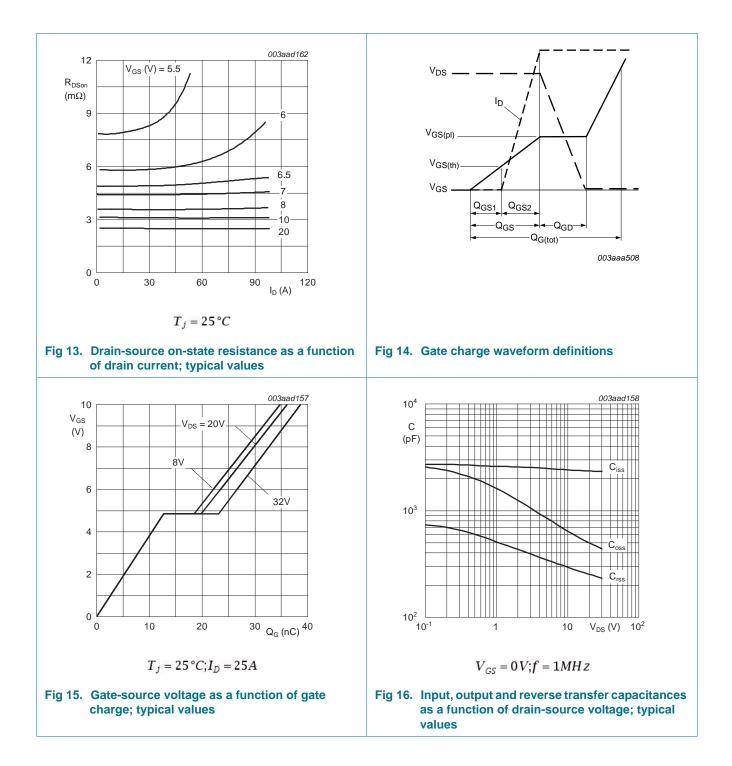
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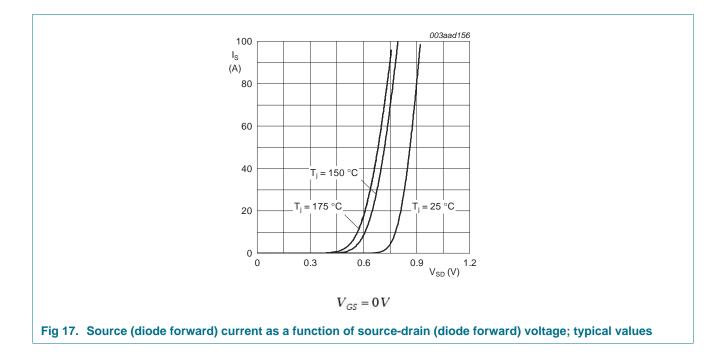
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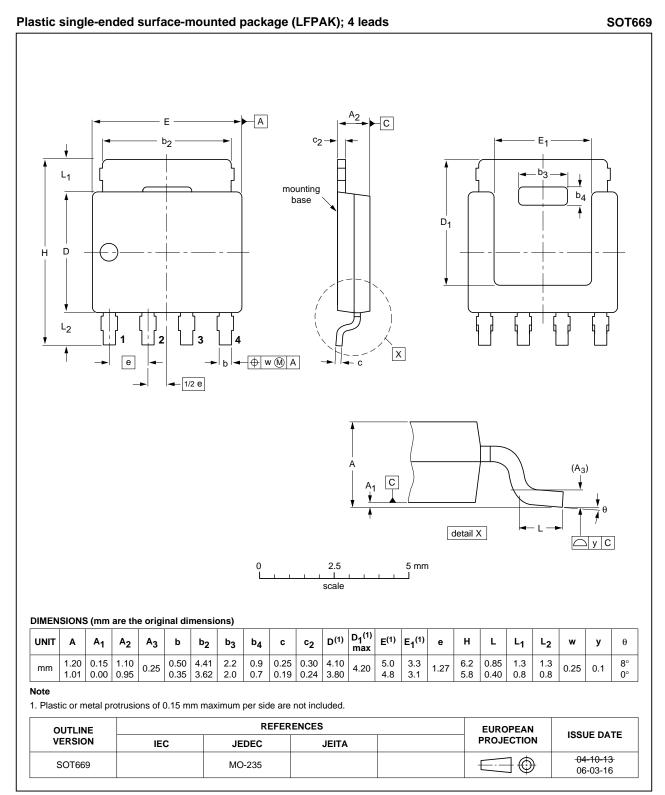
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### 7. Package outline



#### Fig 18. Package outline SOT669 (LFPAK)

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### 8. Revision history

Table 7. Revision h	nistory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN4R0-40YS v.2	20100712	Product data sheet	-	PSMN4R0-40YS v.1
Modifications:	<ul> <li>Various changes</li> </ul>	to content.		
PSMN4R0-40YS v.1	20090625	Product data sheet	-	-

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Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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